

Search Notes

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Examiner

Edward Wojciechowicz

Applicant(s)/Patent under
Reexamination

BYEON ET AL.

Art Unit

2815

SEARCHED

Class	Subclass	Date	Examiner
257	30	4-10-06	EA

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
See search history	4-10-06	EA